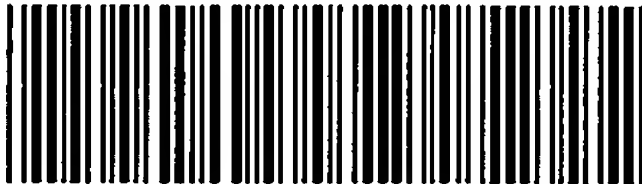


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/617,171	JEONG, KI-TAG	
	Examiner	Art Unit	
	Tianjie Chen	2652	

SEARCHED			
Class	Subclass	Date	Examiner
Updated		10/13/2005	TJ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR